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Substitute (for form 1449A/PT()		Complete if Known				
				Application Number	Not Known 10/705,495			
INFO	RMATION (DISC	LOSURE	Filing Date	11/10/2003			
STAT	EMENT BY	' AP	PLICANT	First Named Inventor	Silver et al.			
				Group Art Unit	2621			
(L	ıse as many sheets	s as nec	essary)	Examiner Name	D. Mariam			
Sheet	1	of	3	Attorney Docket Number	C97-050 CON12			

			U.S. PATENT DOCUMEN	TS	
xaminer nitials*	Cite No.1	U.S. Patent Document Kind Code ² Number (if known)	Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Cfg 23/5 Ligures Appear
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Examiner Initials*	Cite No.'	Office ³	Number ⁴	Kind Code ⁵ (if known)	Name of Patentee or Applicant of Cited Document	Cited Document MM-DD-YYYY	Where Relevant Passages or Relevant Figures Appear	T
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¹Unique citation designation number. ²See attached Kinds of U.S. Patent Documents. ³Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). ¹For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. ⁵Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. ⁸Applicant is to place a check mark here if English language Translation is attached.

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OTHER PRIO	R ART -	NON PATENT LITERATURE DOCUMENTS	
Examiner Initials*	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T²
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1	Signature				Considered	08	04	2004	
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Substit	ute for form 1449B/P	то		Complete if Known			
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INF	ORMATION	DISC	LOSURE	Filing Date	11/10/2003		
STA	ATEMENT B	Y AP	PLICANT	First Named Inventor	Silver et al.		
				Group Art Unit	2621		
	(use as many shee	ts as ne	cessary)	Examiner Name	D. Mariam		
Sheet	3	of	3	Attorney Docket Number	C97-050_CON12		

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Examiner Initials*	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²
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